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(REV. 2-82)	Patent and Trademark Office	

Atty. Docket No. 036179/US/2-475387-30

Serial No. 10/577,562

## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(Use several sheets if necessary)

Applicant(s) Seok-Hyun Yun

Filing Date April 27, 2006 Confirmation No. 3634

**U.S. PATENT DOCUMENTS** 

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*Exam. Init.				Docun	nent N	0.			Date	Name	Class	Subclass	Filing Date if Appropriate
*****		6	3	4	1	0	3	6	January 22, 2002	Tearney et al. $ΩΩΩΩΩ$			
		6	3	9	6	9	4	1	May 28, 2002	Bacus, James W. et al. $\Omega\Omega\Omega\Omega\Omega\Omega$			
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		6	5	6	7	5	8	5	May 20, 2003	Martin et al ΩΩΩΩΩΩΩ			
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		7	2	6	7	4	9	4	September 11, 2007	Hongyu et al. $ΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩΩ$			
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		4	8	2	7	9	0	7	May 9, 1989	Tashiro et al. $\Omega\Omega\Omega\Omega\Omega\Omega\Omega\Omega\Omega$ $\Omega\Omega$			
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	200	3		2	0	1	3	7	June 26, 2003	Pawluczyk et al			

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<sup>\*</sup> Examiner: Initial citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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10577562 - GAU: 2877 Receipt date: 07/27/2009 Page 2 of 6 Serial No. Form PTO-1449 U.S. Department of Commerce Atty. Docket No. (REV. 2-82) Patent and Trademark Office 036179/US/2-475387-30 10/577,562 INFORMATION DISCLOSURE STATEMENT Applicant(s) BY APPLICANT Seok-Hyun Yun (Use several sheets if necessary) Confirmation No. Filing Date April 27, 2006 3634 Chaiken et al. ¥¥ July 11, 2002 200 Kleen Martin et July 28, 2005 2005 0 6 0 3 al. ¥¥¥ Toida 200 5 7 May 2, 2002 Masahiro¥¥¥ Mandrusov January 1, 2004 200 Evgenia et al. Fischman, Alan et al. <del>YYY</del> 200 May 1, 2003 Kittrell, Carter 0 4 3 April 19, 1994 5 3 1 et al. <del>YYY</del> Choma et al. 3 3 6 3 6 6 February 26, 2008 Izatt et al. 8 March 28, 2006 0 1 9 8 3 Toida et al. April 16, 2002 6 3 7 4 1 2 8 Eguchi et al. 7 0 3 November 5, 2002 6 4 4 Miyagawa et al. <del>YYYY</del>l 7 September 10, 1996 5 5 5 0 8 Fang-Yen et al March 17, 2005 YYYY 200 Q February 17, 2005 Bouma et al. Casscells, III et 200 February 6, 2003 Ryan et al. 200 3 0 9 0 4 8 May 22, 2003 7

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Form PTO-1449 U.S. Department of Commerce (REV. 2-82) Patent and Trademark Office	Atty. Docket No. 036179/US/2-475387-30	Serial No. 10/577,562				
INFORMATION DISCLOSURE STATEMENT BY APPLICANT	Applicant(s) Seok-Hyun Yun					
(Use several sheets if necessary)	Filing Date April 27, 2006	Confirmation No. 3634				
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